

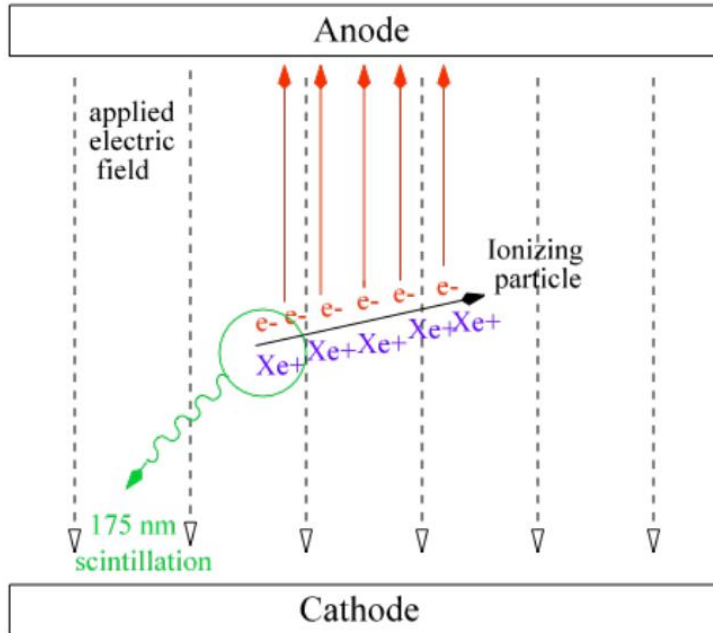


nEXO: The Next Generation Double-Beta Decay Experiment

Results of nEXO detector development

Thomas Brunner for the nEXO collaboration
TAUP2017– July 25, 2017

Searching for $0\nu\beta\beta$ in ^{136}Xe with EXO

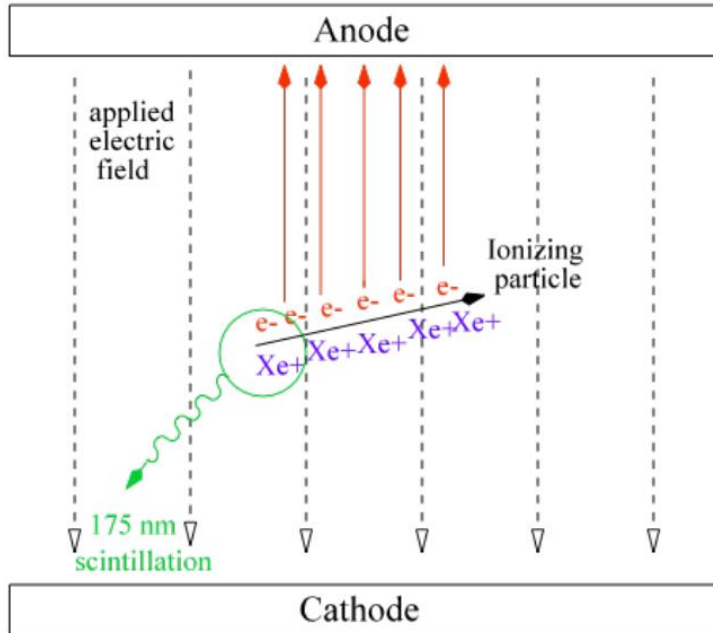


Liquid-Xe Time Projection Chamber

- Liquid Xe at 168K
- Cryogenic electronics in LXe
- Detection of scintillation light and secondary charges
- 2D read out of secondary charges at segmented anode
- Full 3D event reconstruction:
 1. Energy reconstruction
 2. Position reconstruction
 3. Event Multiplicity

See talks by
C. Licciardi and
R. MacLellan

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Development focuses on:

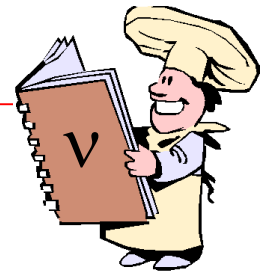
- High voltage
- Light detection
- Charge detection
- Radioassays
- (Ba-tagging)

See talk by
Chris Chambers

$T_{1/2}^{0\nu} > 10^{25}$ years !!

→ Need:

- high target mass
- high exposure
- low background rate
- good energy resolution



Advantages of nEXO

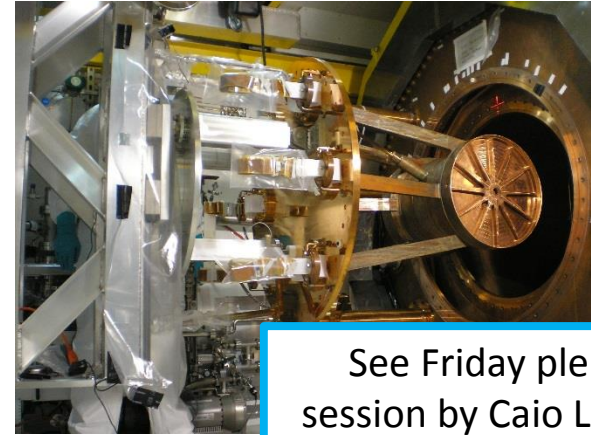
Build on the experience gained and the success of EXO-200 using well established techniques

1. **Energy measurement**
2. **Event multiplicity** (γ 's Compton scatter depositing energy in more than one site in large detectors).
3. **Depth in the detector (or distance from the walls)** is (for large monolithic detectors) a powerful parameter for discriminating between signal and (external) backgrounds.
4. **α discrimination** (from e^- / γ), possible in many detectors.

Take full advantage of monolithic detector!

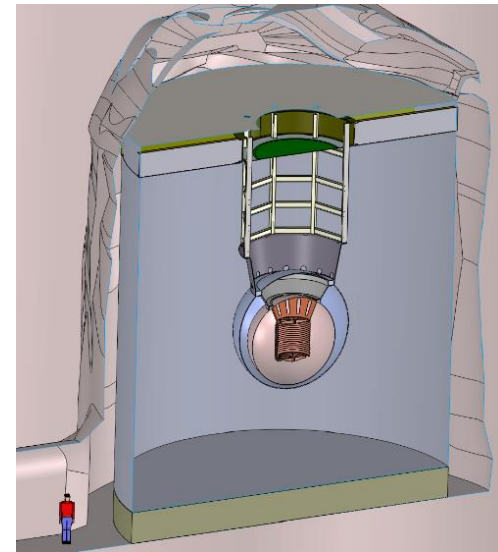
Phased approach:

1. EXO-200: 200kg liquid-Xe TPC



See Friday plenary session by Caio Licciardi

2. nEXO: 5-ton liquid Xe TPC with Ba tagging option (SNO lab cryopit)



The nEXO TPC

Long, single drift

- HV
- Xe purity (low outgassing)

Novel charge tiles

- very low noise
- modularity
- self-supporting

SiPMs on the barrel

- optically open, reflective field cage
- no HV required
- Robust
- larger gain
- large scale production

In-Xe electronics

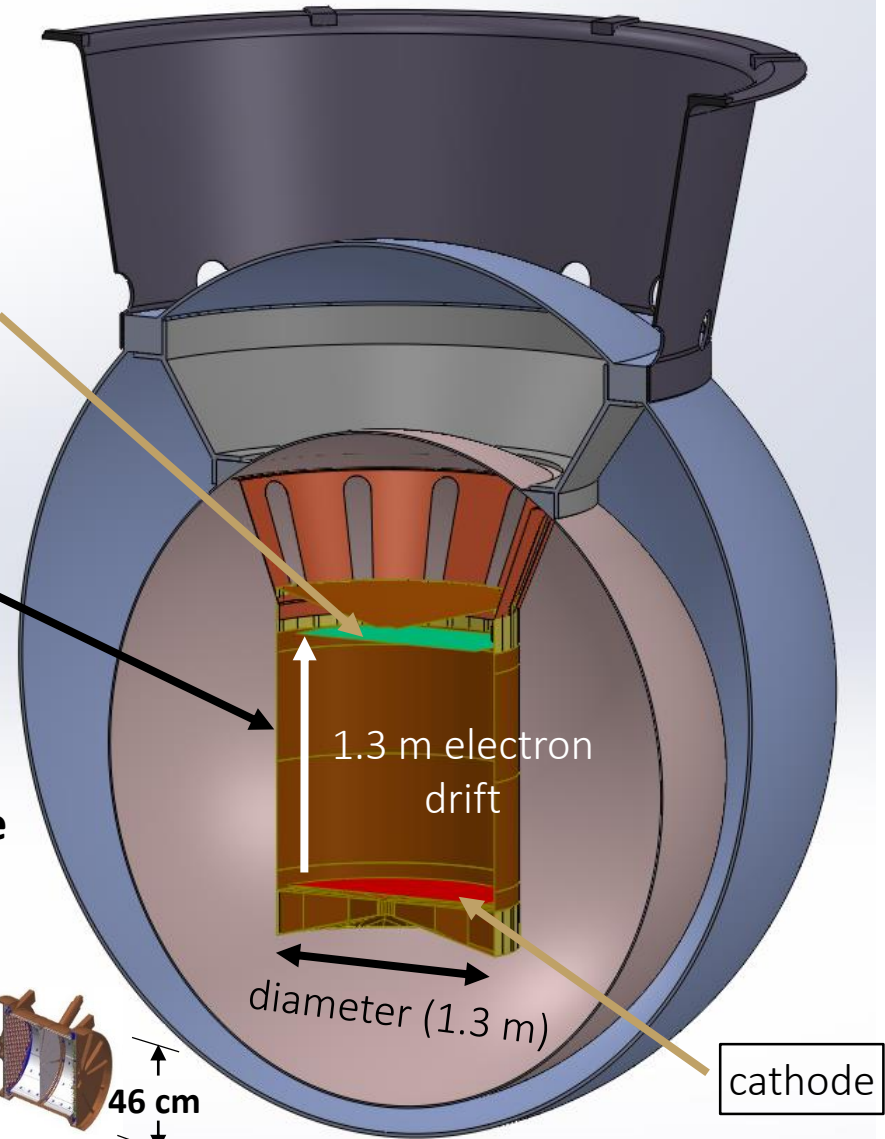
- radioactivity

charge strip-pad tiles (anode)

SiPM 'staves' coating the barrel

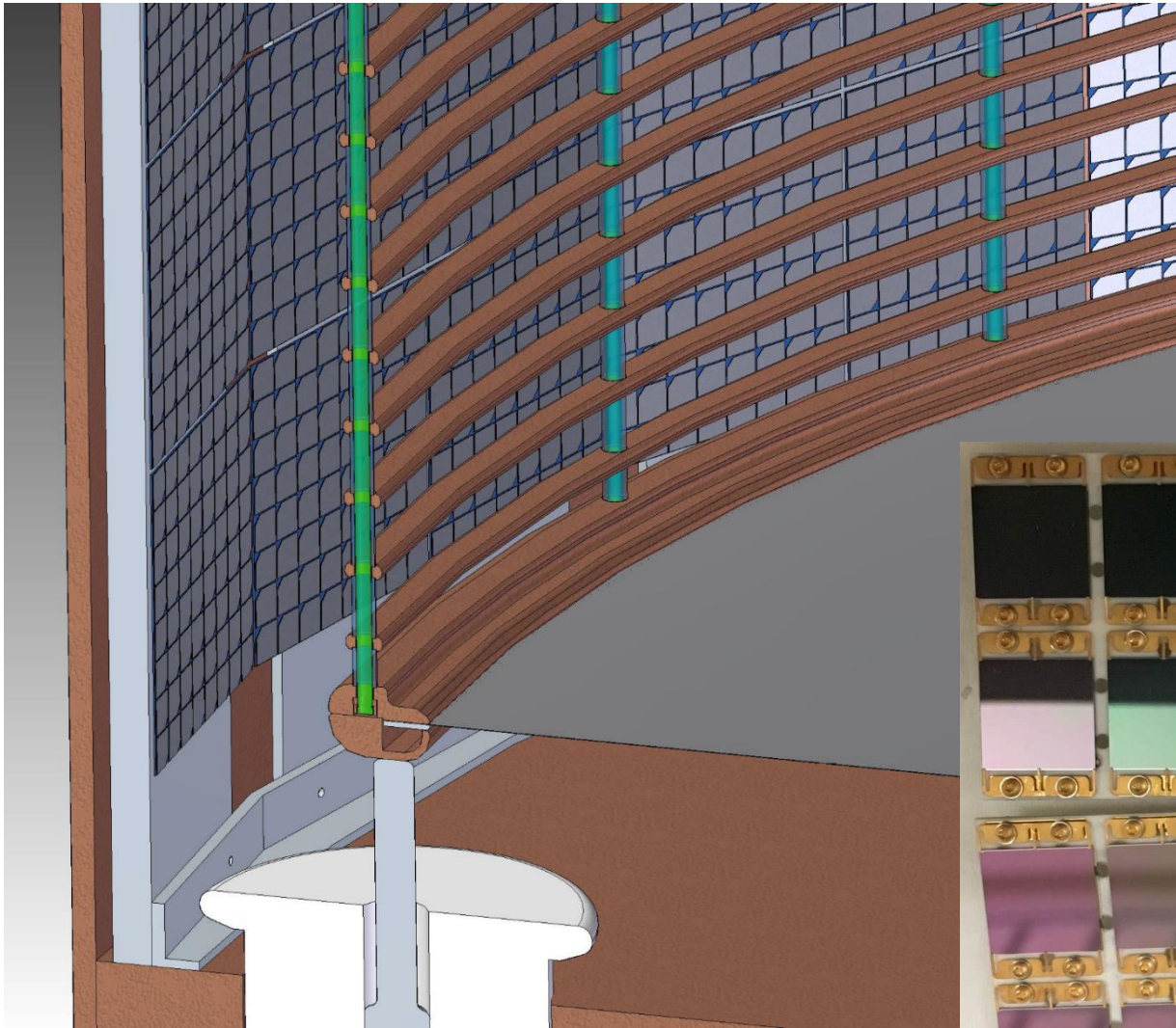
EXO-200 for size comparison

in-xenon cold electronics (charge and SiPMs)



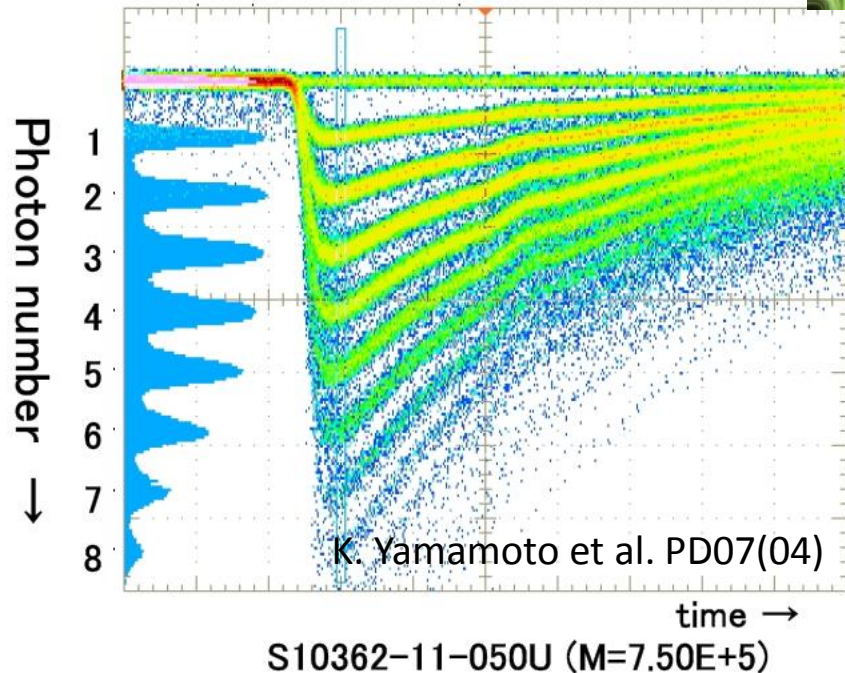
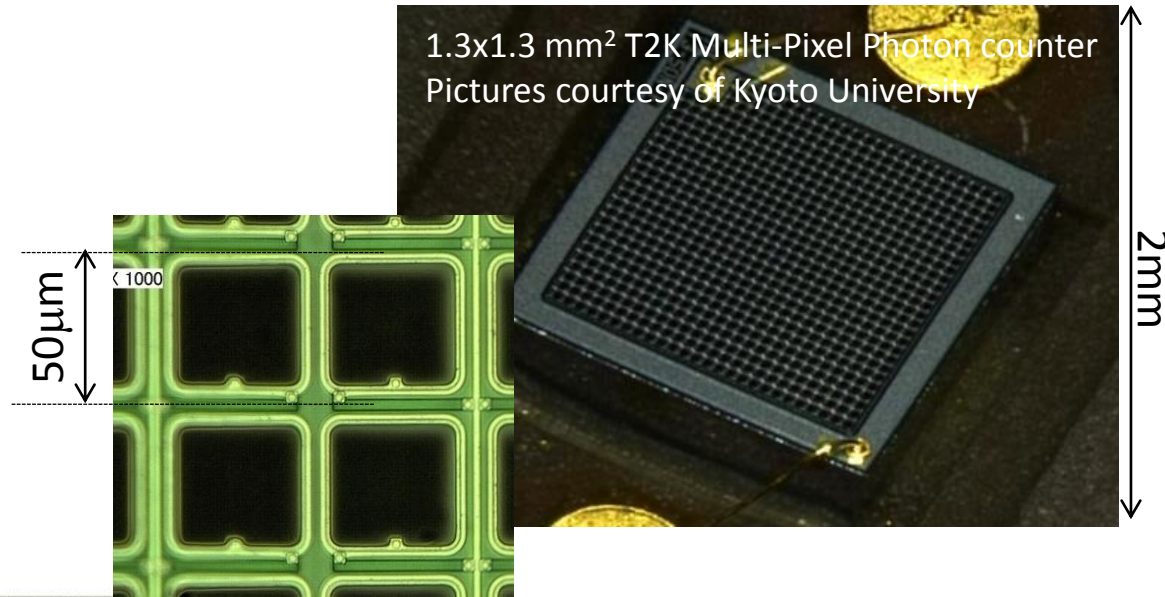
Photon sensors

- Need $\sim 4\text{m}^2$ of VUV-sensitive SiPMs
- SiPMs and electronics mounted in LXe
- Increase photon detection efficiency through reflective surfaces



Analog SiPMs - baseline solution for nEXO

- High gain (low noise)
- Large manufacturing capabilities ($> 4 \text{ m}^2$)
- But efficiency and radioactivity need work

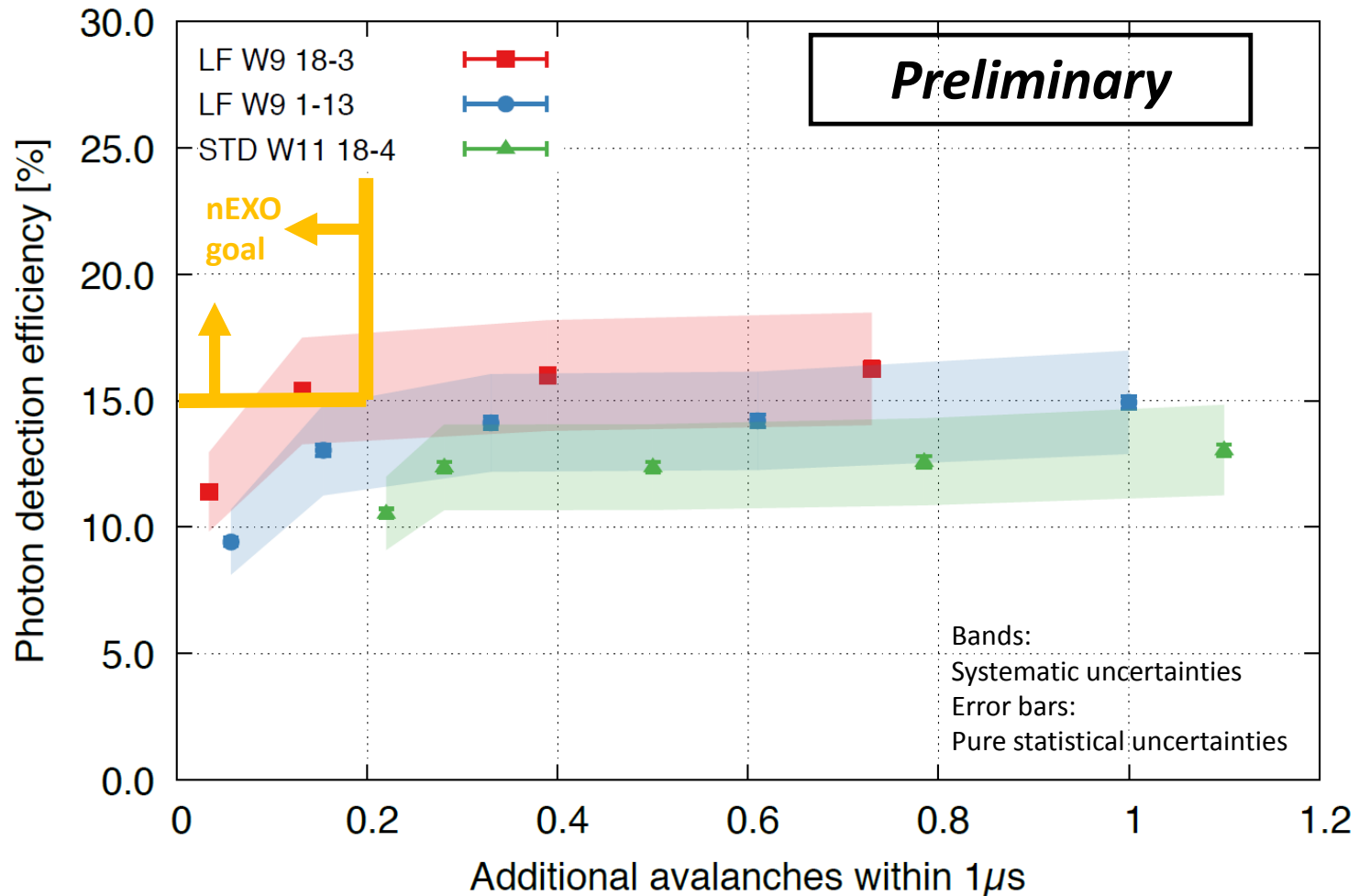


Requirements:

- Efficiency at 175nm $> 15\%$
- Correlated avalanche rate $< 20\%$
- Dark noise rate $< 50\text{Hz}/\text{mm}^2$
- Low radioactivity

SiPM Photodetector

At least one type of 6 x 6 mm² VUV devices now match our desired properties, with a bias requirement ~30V (as opposed to the 1500V of EXO-200 APDs)

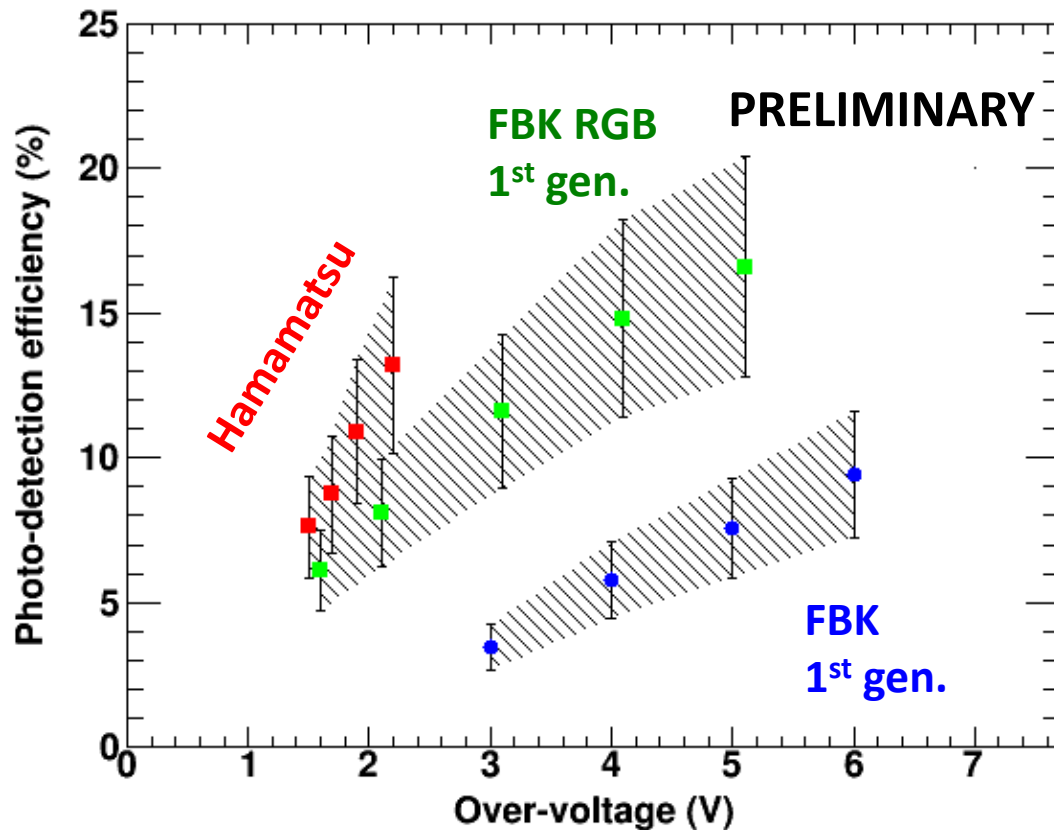


FBK low field SiPM: Th = 0.45 \pm 0.12 ppt, U = 0.86 \pm 0.05 ppt

FBK standard field SiPM: Th = 0.44 \pm 0.05 ppt, U = 0.99 \pm 0.02 ppt

SiPM Photodetector

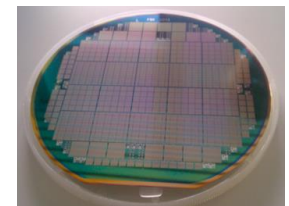
- Hamamatsu produces devices with $QE > 15\%$ @ 175nm but encapsulation is too radioactive \rightarrow trying to procure un-encapsulated devices
- First nEXO-specific run at FBK (Italy) provided $\sim 10\%$ QE [I.Ostrovskiy et al. IEEE TNS 62 (2015) 1825.]
- New FBK “RGB” devices reach 15% QE with $7.7 \times 7.7 \text{mm}^2$.



- Working closely with manufacturers to develop SiPMs to reach $> 15\%$ QE at 175nm
- ^{232}Th and ^{238}U content of FBK SiPMs found to be < 1 ppt
- Development of integration of $1 \times 1 \text{cm}^2$ SiPMs into $10 \times 10 \text{cm}^2$ tiles
- **First tests in liquid Xe**



Hamamatsu MEG MPPC

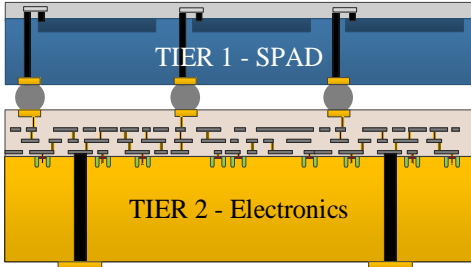


FBK SiPM

3D-integrated dSiPM for nEXO

Advantages over analog SiPM + analog electronics

- All in one chip assembly: **photon come in, bits come out**
- Power scales with avalanche count not with capacitance
- Allow lower power or better timing resolution and granularity
- After-pulsing can be completely eliminated for a given time scale

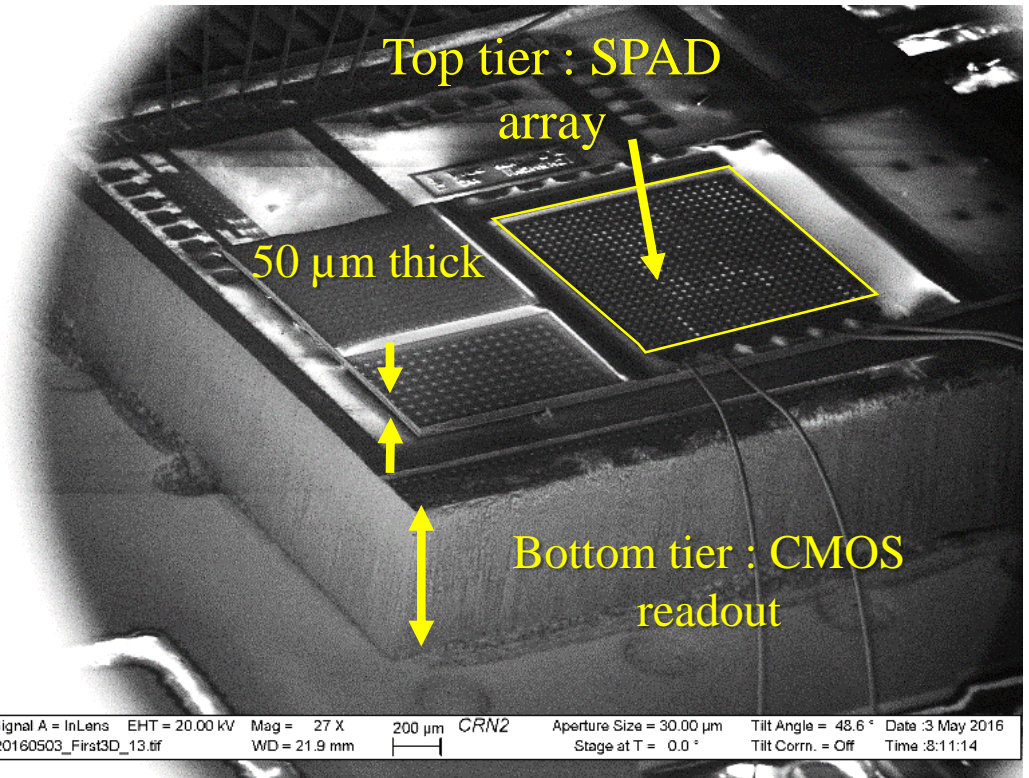
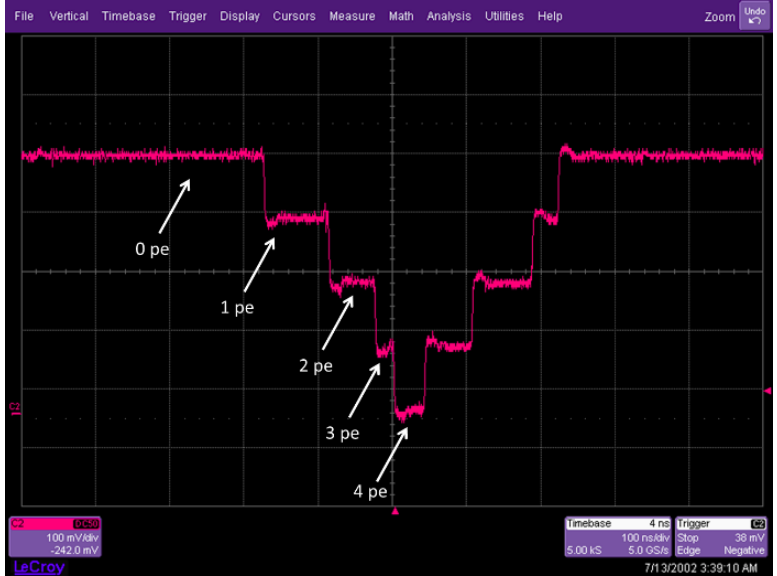


nEXO radio assay showed sub-ppt Th/U purity

Challenges

- Need custom SPAD array
- Large scale scaling
- Significant R&D required

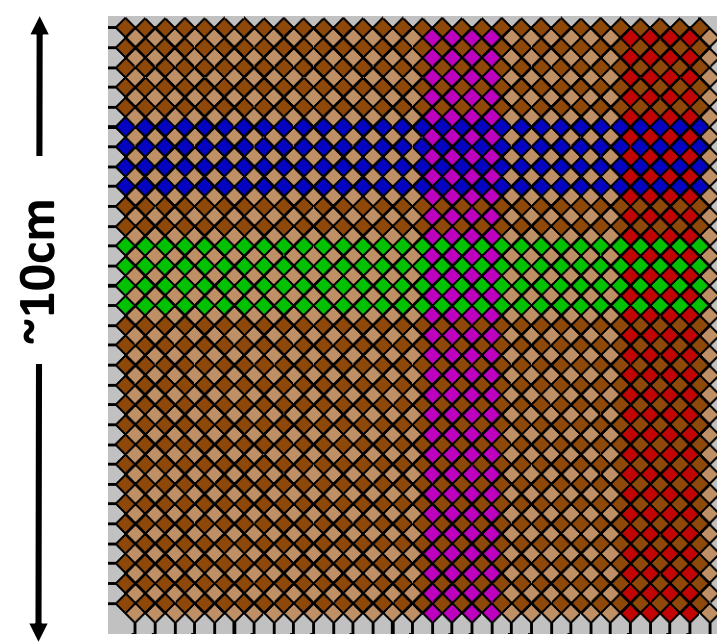
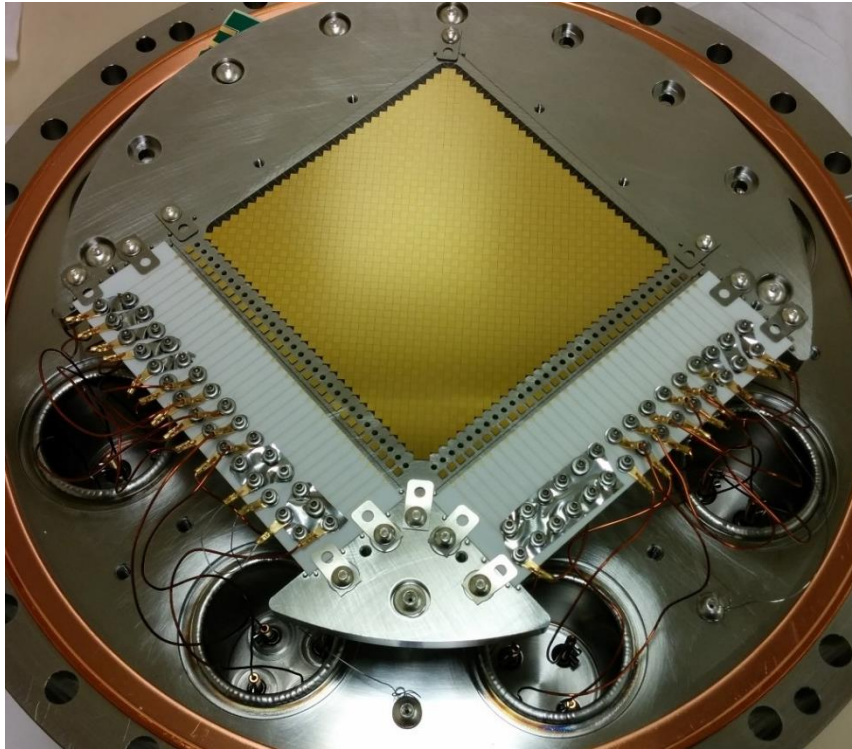
See talk by Serge Charlebois



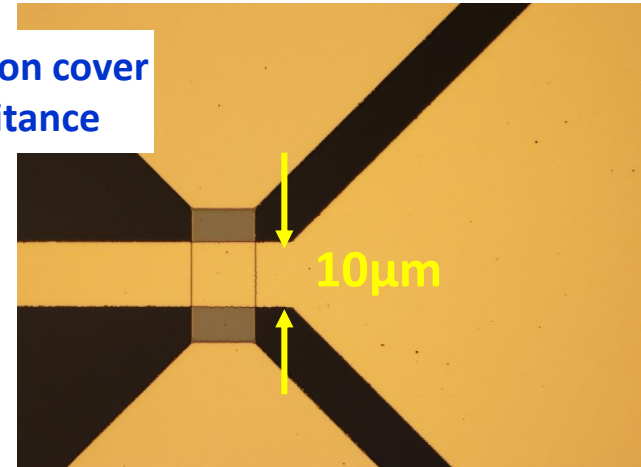
Charge Readout

Charge will be collected on arrays of strips fabricated onto low background dielectric wafers (low radioactivity quartz has been identified)

- Self-supporting/no tension
- Built-on electronics (on back)
- Far fewer cables
- Ultimately more reliable, lower noise, lower activity



Max metallization cover with min capacitance



- 10 x 10cm² Prototype Tile
- Metallized strips on fused silica substrate
- 60 orthogonal channels (30 x 30), 3mm strip pitch
- Strip intersections isolated with SiO₂ layer

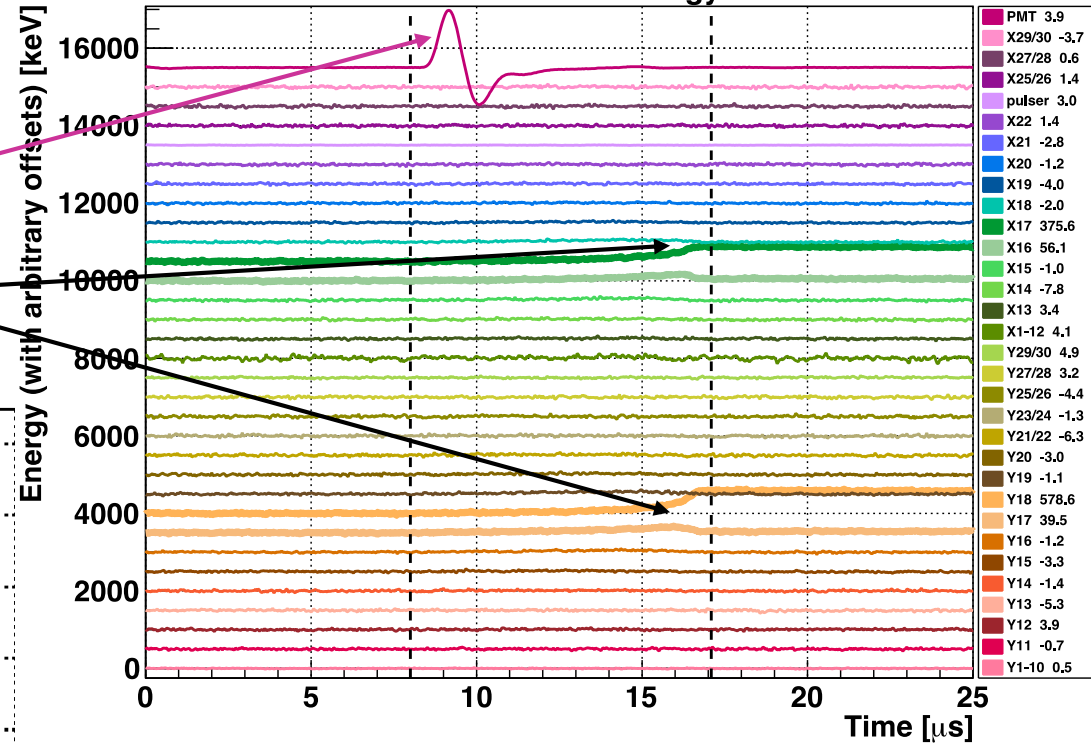
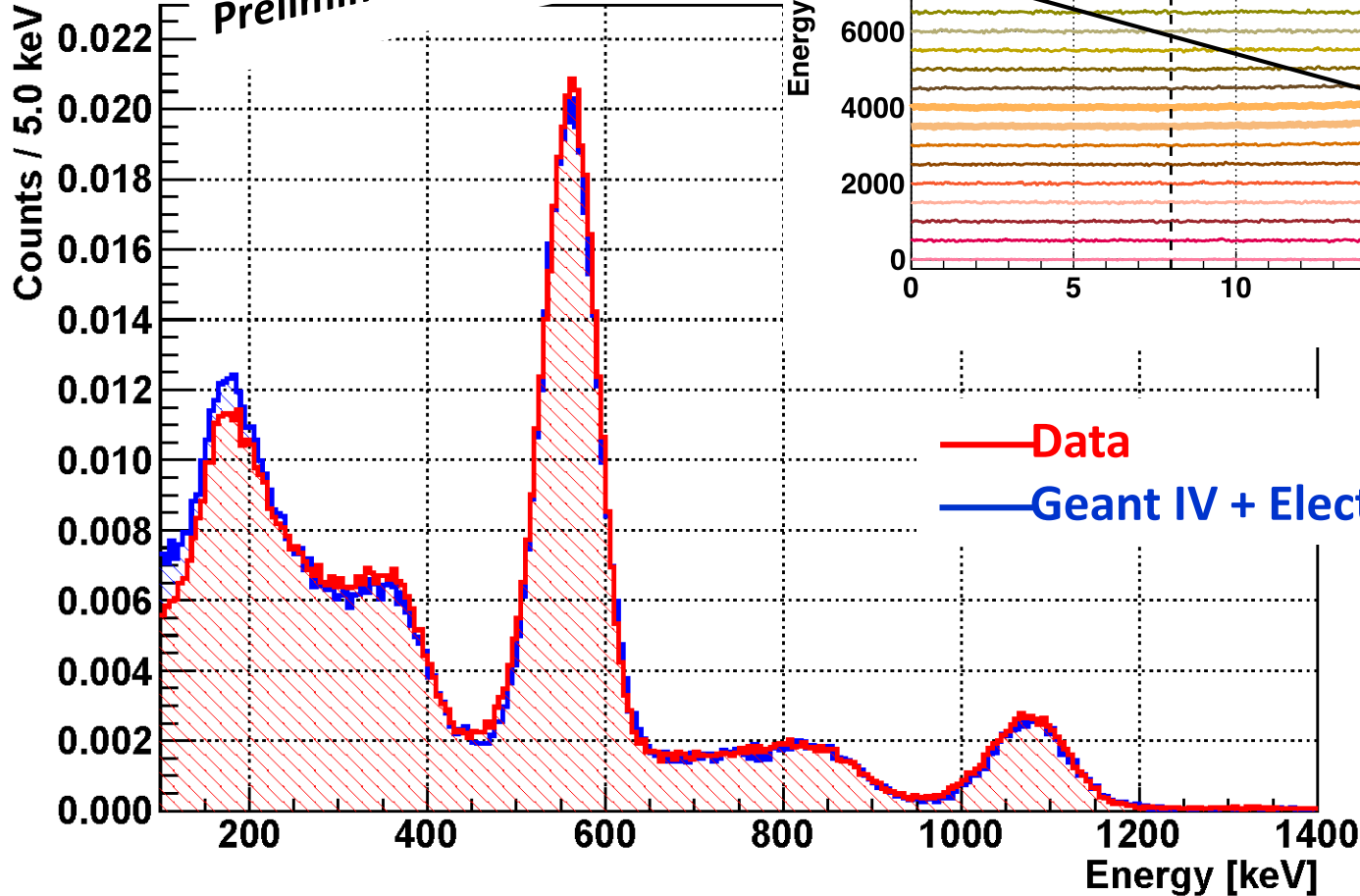
Charge Readout

Event 360 I Sum Ionization Energy: 1049.8 keV

PMT (trigger)

Charge collection

Preliminary



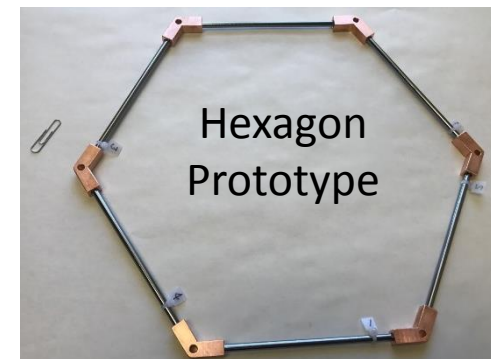
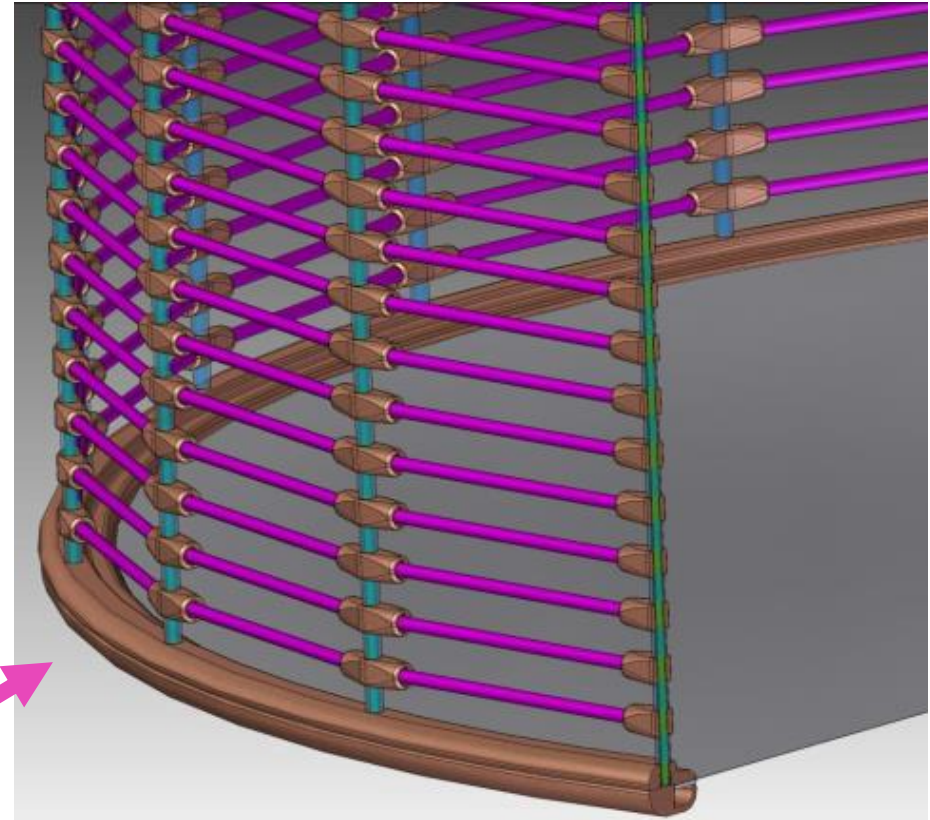
High Voltage R&D

Focus of development

- Spark mitigation → stable operation up to -100 kV
- Protection of electronics and detector in case of HV breakdown
- High reflectivity at 175 nm
- Low radioactivity

Ideas:

- High-resistivity Si field shaping rings to limit spark current
- Reflective coating of cathode and field-shaping rings



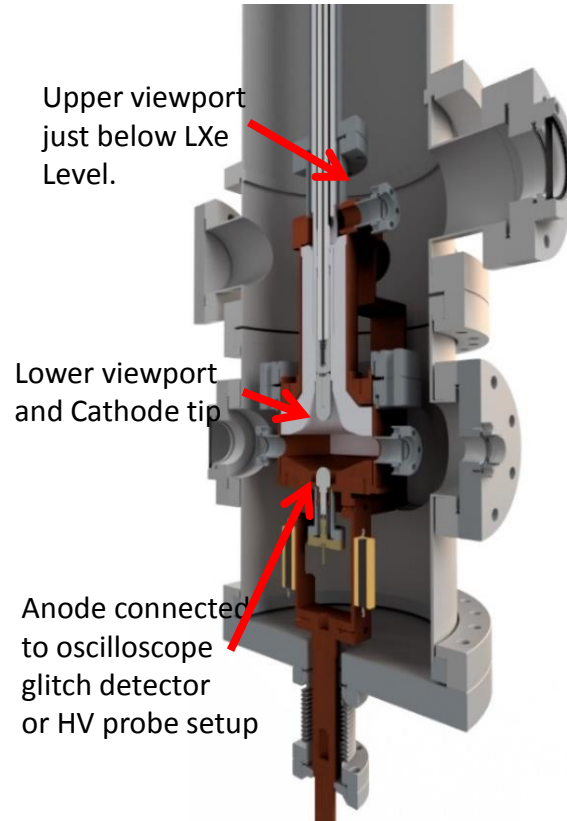
High Voltage R&D test setups

30l LXe Bern HV test setup now at **Carleton U.** with cryogenic cameras



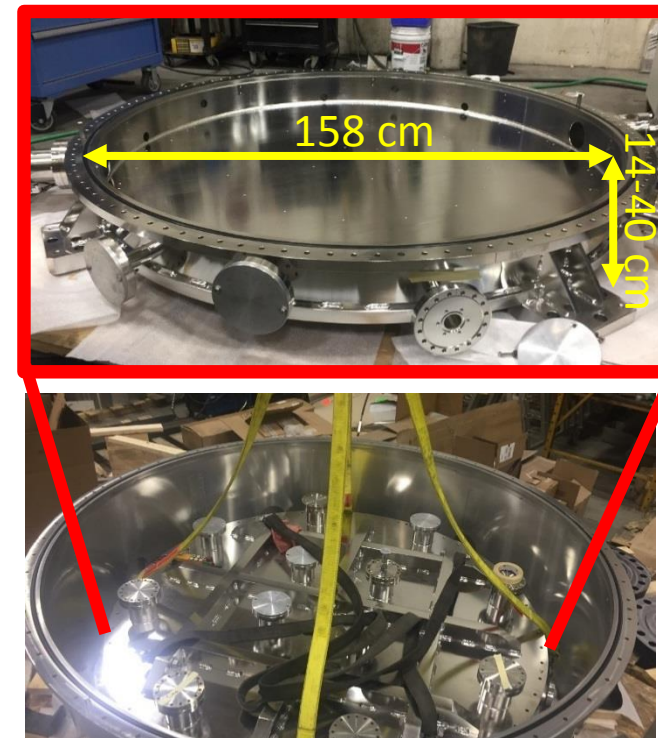
HV tests of ~30cm scale geometries

400 cc LXe HV setup at **SLAC**



Test of breakdown voltage in LXe for different small size geometries

Max 800 kg LXe setup at **LLNL** to accommodate full or near-full size parts horizontally (under development)



HV tests in LXe for different full-nEXO diameter size geometries

Radioactivity studies of materials for nEXO

Techniques applied:

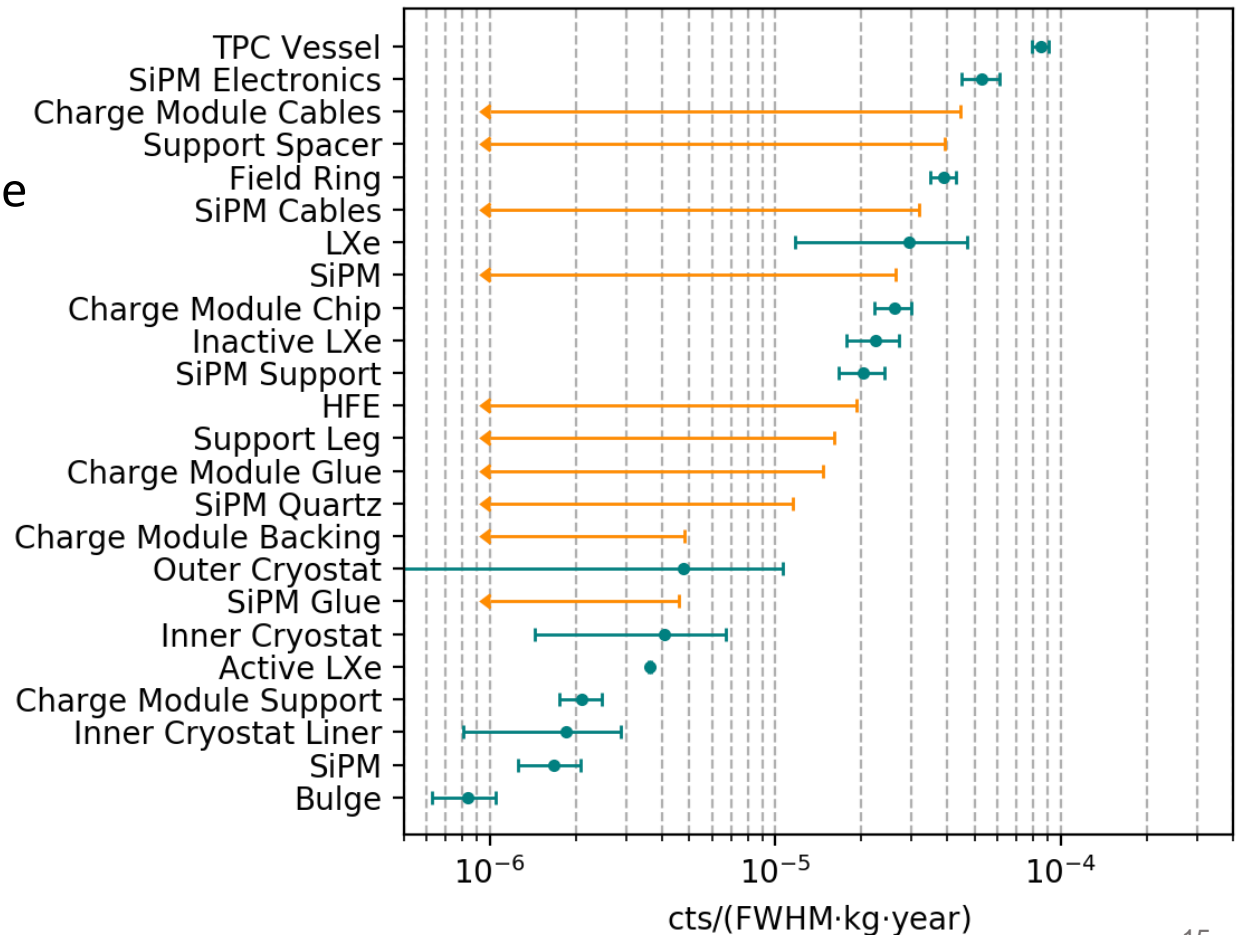
- Ge detector counting
- Neutron-activation analysis
- Inductively-Coupled Plasma Mass Spectrometry (IC PMS)

See talk by Ryan MacLellan
See poster by John Orrell

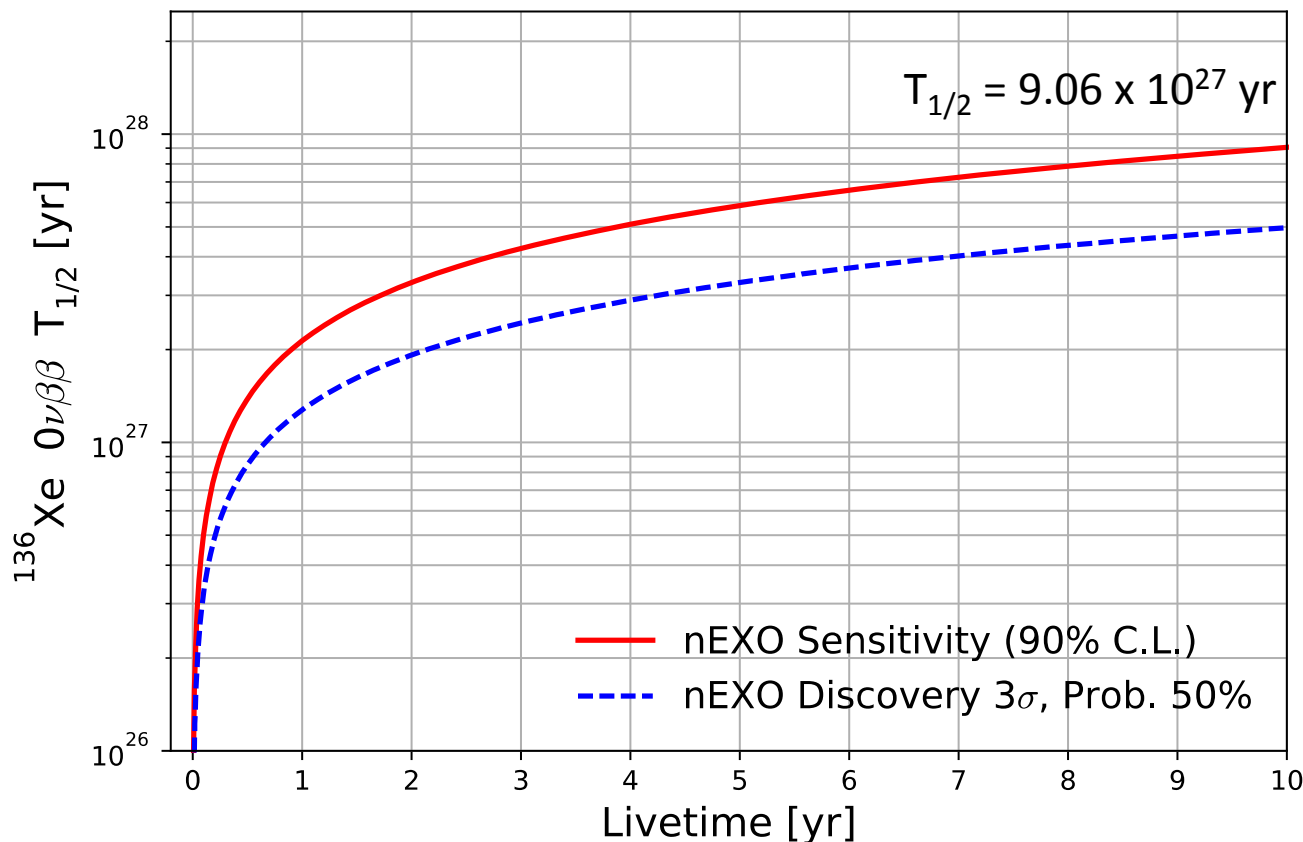
nEXO background budget by component

- TPC internals dominate (as expected)
- Several radioassay entries with only 90% CL limit

Great effort spent on measuring radioactive backgrounds and identifying suitable materials for nEXO.



nEXO Sensitivity & Discovery Potential



Methodology:

- 90% enrichment
- 1% $\sigma E/E$ resolution
- **Realistic background projections based on measurements**
- EXO-200-like analysis

- nEXO is the next generation $0\nu\beta\beta$ experiment with 5 T enriched LXe
- nEXO expands on the success of EXO-200 and improves performance via R&D efforts
- nEXO baseline R&D is well advanced

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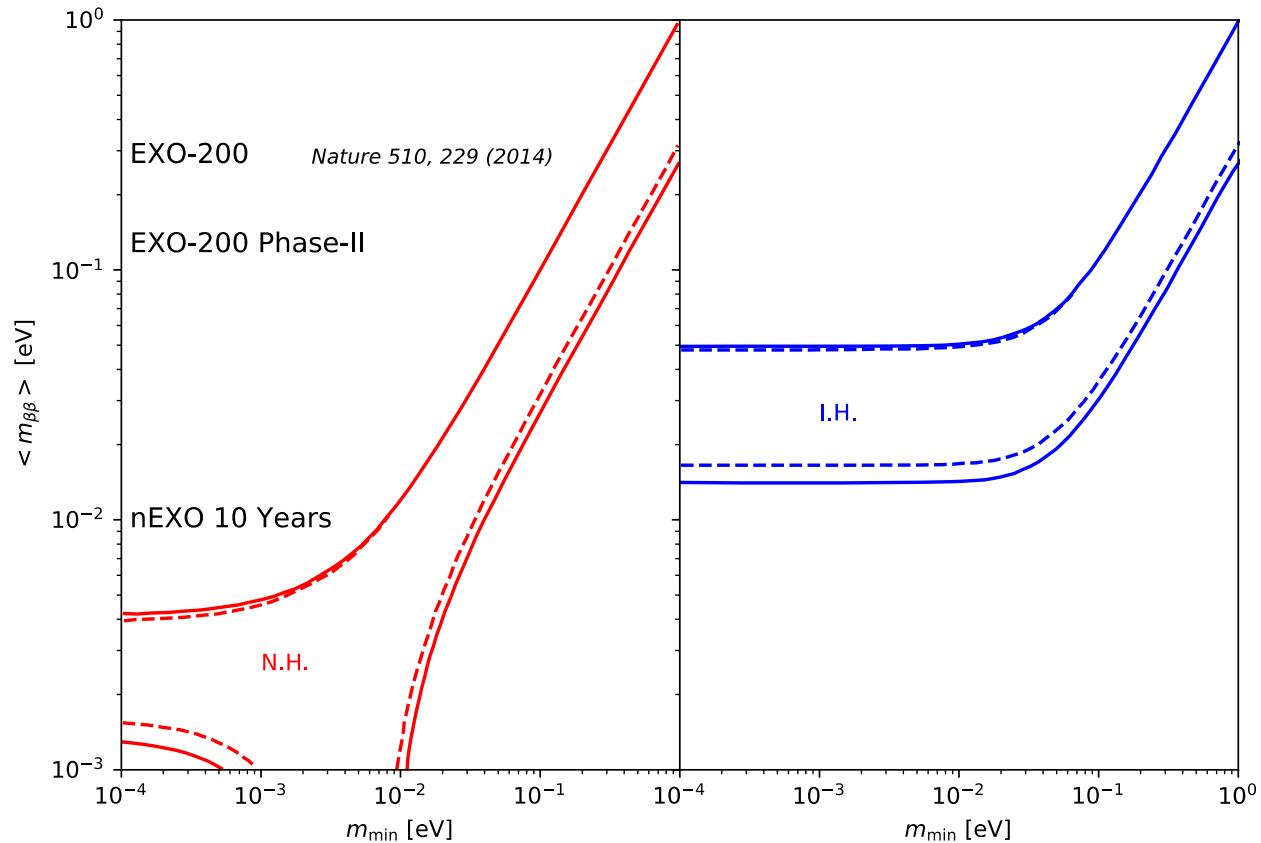


The nEXO Collaboration



Backup

nEXO Sensitivity to Neutrino Mass



- Allowed neutrino mass bands:
90% CL, Forero et al., PRD 90 (2014)
Forero et al., private comm.
- Based on 10yr Sensitivity of 9.06×10^{27} y

Calculation	Value	Mass [meV]	
Skyrme-QRPA	1.55	17.78	PRC.87.064302.2013
QRPA-Tu	2.18	12.64	PRC.91.034304.2015
RQRPA	2.54	10.85	PRC.91.024316.2015
NREDF	4.77	5.78	PRC.91.024316.2015
REDF	4.32	6.38	PRC.91.024316.2015
ISM	2.32	11.88	NPA.818.139.2009
IBM-2	3.05	9.04	PRC.91.034304.2015